

<b>Notice of References Cited</b>	Application/Control No. 10/698,666		Applicant(s)/Patent Under Reexamination HUSTED, PAUL J.	
	Examiner Siu M. Lee		Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,690,746 B1	02-2004	Sills et al.	375/316
*	B	US-4,166,980	09-1979	Apostolos et al.	375/316
*	C	US-2004/0030530 A1	02-2004	Li et al.	702/179
*	D	US-5,644,597	07-1997	Ueda, Koji	375/232
*	E	US-6,571,083 B1	05-2003	Powell et al.	455/69
*	F	US-7,161,987 B2	01-2007	Webster et al.	375/260
*	G	US-6,957,086 B2	10-2005	Bahl et al.	455/557
*	H	US-4,845,707	07-1989	Isaacson et al.	370/480
*	I	US-6,463,107 B1	10-2002	Lindoff et al.	375/343
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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